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Randal W. Tustison
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Contents

vii *Conference Committee*

SESSION 1 LONG-WAVELENGTH INFRARED TRANSPARENT MATERIALS

- 654502 **Development of hot-pressed and chemical-vapor-deposited zinc sulfide and zinc selenide in the United States for optical windows (Invited Paper)** [6545-01]
D. C. Harris, Naval Air Systems Command (USA)
- 654503 **International development of chemical vapor deposited zinc sulfide** [6545-02]
J. McCloy, Raytheon Missile Systems (USA)
- 654504 **Optical properties of epitaxial single-crystal chemical-vapor-deposited diamond** [6545-03]
G. Turri, Y. Chen, M. Bass, CREOL/College of Optics and Photonics/Univ. of Central Florida (USA); D. Orchard, QinetiQ Ltd. (United Kingdom); J. E. Butler, S. Magana, T. Feygelson, D. Thiel, K. Fourspring, Naval Research Lab. (USA); J. Pentony, S. Hawkins, M. Baronowski, R. V. Dewees, M. D. Seltzer, A. Guenther, D. C. Harris, Naval Air Systems Command (USA); C. M. Stickley, DARPA (USA)
- 654505 **Spectral characterization of diffractively structured GaAs using the ARISTMS** [6545-04]
P. Coulter, M. Wilson, MilSys Technologies, LLC (USA)

SESSION 2 GLASSES

- 654507 **Fluorinated silicate glass for conventional and holographic optical elements** [6545-06]
L. Glebov, CREOL/College of Optics and Photonics/Univ. of Central Florida (USA)
- 654508 **Development of a laser glass for the National Ignition Facility** [6545-07]
J. S. Hayden, SCHOTT North America, Inc. (USA); J. H. Campbell, S. A. Payne, Lawrence Livermore National Lab. (USA)

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The CID number appears on each page of the manuscript. The complete citation is used on the first page, and an abbreviated version on subsequent pages.

SESSION 3 MICRO- AND NANO-CRYSTALLINE OPTICAL MATERIALS AND STRUCTURES

- 654509 **Spark plasma sintering and forming of transparent polycrystalline Al₂O₃ windows and domes** [6545-49]
D. Jiang, D. M. Hulbert, U. Anselmi-Tamburini, T. Ng, D. Land, A. K. Mukherjee, Univ. of California, Davis (USA)
- 65450A **Nanocomposite optical ceramics for infrared windows and domes** [6545-09]
T. Stefanik, R. Gentilman, P. Hogan, Raytheon Integrated Defense Systems (USA)
- 65450E **Polycrystalline yttrium aluminum garnet (YAG) for IR transparent missile domes and windows** [6545-13]
J. C. Huie, Raytheon Integrated Defense Systems (USA); C. B. Dudding, J. McCloy, Raytheon Missile Systems (USA)

SESSION 4 MODELING, CHARACTERIZATION, AND FABRICATION I

- 65450F **Optical properties of Nd doped and undoped polycrystalline YAG** [6545-15]
M. E. Thomas, A. K. Carr, D. Limsui, Johns Hopkins Univ. Applied Physics Lab. (USA); J. C. Huie, Raytheon Integrated Defense Systems (USA)
- 65450G **Erosion studies of infrared dome materials** [6545-16]
R. M. Sullivan, Naval Air Warfare Ctr. (USA); A. Phelps, Univ. of Dayton Research Institute (USA); J. C. Kirsch, U.S. Army Aviation and Missile RDEC (USA); E. A. Welsh, Lockheed Martin Missiles and Fire Control (USA); D. C. Harris, Naval Air Systems Command (USA)
- 65450I **BRDF and BSDF models for diffuse surface and bulk scatter from transparent windows** [6545-18]
M. E. Thomas, Johns Hopkins Univ. Applied Physics Lab. (USA); D. D. Duncan, Oregon Health and Science Univ. (USA)
- 65450J **Application of nondestructive optical techniques in the detection of surface and subsurface defects in sapphire** [6545-19]
I. A. Akwani, D. L. Hibbard, K. T. Jacoby, Exotic Electro-Optics (USA)
- 65450K **Characterization of AFB sapphire single crystal composites for infrared window application** [6545-20]
H.-C. Lee, H. E. Meissner, Onyx Optics, Inc. (USA)
- 65450L **Simulation and experimental results of sub-aperture transmitted wavefront measurements of a window using a time-delayed source** [6545-21]
M. B. Dubin, Breault Research Organization (USA); W. P. Kuhn, Opt-E (USA)

SESSION 5 MODELING, CHARACTERIZATION, AND FABRICATION II

- 65450N **Transmitted wavefront metrology of hemispheric domes using scanning low-coherence dual-interferometry (SLCDI)** [6545-23]
D. W. Diehl, C. Cotton, C. J. Ditchman, B. Statt, ASE Optics, Inc. (USA)
- 65450O **Time-delayed source and interferometric measurement of domes and windows** [6545-24]
W. P. Kuhn, Opt-E (USA); M. Dubin, Breault Research Organization (USA)

- 65450P **Laser-assisted pre-finishing of optical ceramic materials** [6545-25]
J. C. Rozzi, O. H. Clavier, M. D. Barton, Create Inc. (USA)
- 65450Q **Developments in the finishing of domes and conformal optics** [6545-26]
A. B. Shorey, W. Kordonski, J. Tracy, M. Tricard, QED Technologies (USA)
- 65450R **Contact mechanics models and algorithms for dome polishing with UltraForm Finishing (UFF)** [6545-27]
C. Bouvier, S. M. Gracewski, S. J. Burns, Univ. of Rochester (USA)
- 65450S **Improving surface figure and microroughness of IR materials and diamond turned surfaces with magnetorheological finishing (MRF)** [6545-28]
C. Supranowitz, C. Hall, P. Dumas, B. Hallock, QED Technologies (USA)

SESSION 6 OPTICAL COATINGS AND SURFACE STRUCTURES

- 65450T **High durability antireflection coatings for silicon and multispectral ZnS** [6545-29]
S. Joseph, O. Marcovitch, Y. Yadin, D. Klaiman, N. Koren, H. Zipin, Rafael-Optical Components Ctr. (Israel)
- 65450V **iDLC: hardcoat for chalcogenide glass and other IR materials** [6545-31]
K. Rogers, J. Ward, Umicore Coating Services (United Kingdom); Y. Guimond, Umicore IR Glass (France)
- 65450X **Effects of mesh voids on insertion loss of metallic mesh coatings** [6545-33]
J. Halman, K. Ramsey, V. Sawtelle, Battelle Memorial Institute (USA)
- 65450Y **Update on the development of high performance anti-reflecting surface relief micro-structures** [6545-34]
D. S. Hobbs, B. D. MacLeod, J. R. Riccobono, TelAztec LLC (USA)

SESSION 7 VISIBLE TO MID-WAVELENGTH INFRARED TRANSPARENT MATERIALS AND APPLICATIONS

- 654512 **An improved soft-chemistry approach to the preparation of spinel powders** [6545-38]
R. Cook, TDA Research, Inc. (USA)
- 654514 **Polycrystalline transparent spinel domes for multimode seeker applications** [6545-40]
A. A. DiGiovanni, A. LaRoche, L. Schubel, L. Fehrenbacher, Technology Assessment and Transfer (USA); D. W. Roy, Consultant (USA)
- 654517 **Critical parameters for grinding large sapphire window panels** [6545-43]
J. R. Bashe, G. Dempsey, I. A. Akwani, K. T. Jacoby, D. L. Hibbard, Exotic Electro-Optics (USA)
- 654519 **Improvements in large window and optics production** [6545-45]
B. Hallock, B. Messner, C. Hall, C. Supranowitz, QED Technologies (USA)

POSTER SESSION

- 65451C **Reduced angle-shift infrared bandpass filter coatings** [6545-48]
B. M. Lairson, J. Mosier, K. Gibbons, J. H. Sternbergh, M. A. George, Deposition Sciences, Inc. (USA)

Author Index

Conference Committee

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Session Chairs

- 1 Long-wavelength Infrared Transparent Materials
Michael E. Thomas, Johns Hopkins University Applied Physics Laboratory (USA)
- 2 Glasses
Richard L. Gentilman, Raytheon Integrated Defense Systems (USA)
- 3 Micro- and Nano-crystalline Optical Materials and Structures
Daniel C. Harris, Naval Air Systems Command (USA)
- 4 Modeling, Characterization, and Fabrication I
John McCloy, Raytheon Missile Systems (USA)

- 5 Modeling, Characterization, and Fabrication II
James C. Kirsch, U.S. Army Research, Development and Engineering
Command (USA) and U.S. Army Aviation and Missile Command (USA)
- 6 Optical Coatings and Surface Structures
Robert J. Ondercin, Air Force Research Laboratory (USA)
- 7 Visible to Mid-wavelength Infrared Transparent Materials and Applications
Joel Askinazi, Goodrich Corporation (USA)